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**April 2016** 

# FGH50T65SQD 650 V, 50 A Field Stop Trench IGBT

#### **Features**

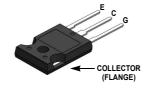
- Maximum Junction Temperature : T<sub>J</sub> =175°C
- · Positive Temperaure Co-efficient for Easy Parallel Operating
- · High Current Capability
- Low Saturation Voltage: V<sub>CE(sat)</sub> =1.6 V(Typ.) @ I<sub>C</sub> = 50 A
- 100% of the Parts Tested for I<sub>LM</sub>(1)
- · High Input Impedance
- Fast Switching
- · Tighten Parameter Distribution
- · RoHS Compliant

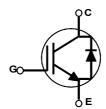
# **General Description**

Using novel field stop IGBT technology, Fairchild's new series of field stop 4<sup>th</sup> generation IGBTs offer the optimum performance for solar inverter, UPS, welder, telecom, ESS and PFC applications where low conduction and switching losses are essential.

#### **Applications**

· Solar Inverter, UPS, Welder, Telecom, ESS, PFC





# **Absolute Maximum Ratings**

| Symbol              | Description   |                          | FGH50T65SQD_F155 | Unit |  |
|---------------------|---|--------------------------|------------------|------|--|
| V <sub>CES</sub>    | Collector to Emitter Voltage  |                          | 650              | V    |  |
| V                   | Gate to Emitter Voltage   |                          | ± 20             | V    |  |
| $V_{GES}$           | Transient Gate to Emitter Voltage                                       |                          | ± 30             | V    |  |
| I <sub>C</sub>      | Collector Current   | @ T <sub>C</sub> = 25°C  | 100              | Α    |  |
| l C                 | Collector Current   | @ T <sub>C</sub> = 100°C | 50               | Α    |  |
| I <sub>LM (1)</sub> | Pulsed Collector Current  | @ T <sub>C</sub> = 25°C  | 200              | Α    |  |
| I <sub>CM (2)</sub> | Pulsed Collector Current  |                          | 200              | Α    |  |
| I <sub>F</sub>      | Diode Forward Current   | @ T <sub>C</sub> = 25°C  | 50               | Α    |  |
| 'F                  | Diode Forward Current   | @ T <sub>C</sub> = 100°C | 30               | Α    |  |
| I <sub>FM</sub>     | Pulsed Diode Maximum Forward Currer                                     | t                        | 200              | Α    |  |
| P <sub>D</sub>      | Maximum Power Dissipation   | @ T <sub>C</sub> = 25°C  | 268              | W    |  |
| . 0                 | Maximum Power Dissipation   | @ T <sub>C</sub> = 100°C | 134              | W    |  |
| T <sub>J</sub>      | Operating Junction Temperature  |                          | -55 to +175      | °C   |  |
| T <sub>stg</sub>    | Storage Temperature Range   |                          | -55 to +175      | °C   |  |
| TL                  | Maximum Lead Temp. for soldering Purposes, 1/8" from case for 5 seconds |                          | 300              | °C   |  |

- Notes: 1.  $V_{CC}$  = 400 V,  $V_{GE}$  = 15 V,  $I_{C}$  = 200 A,  $R_{G}$  = 3  $\Omega$ , Inductive Load
- 2. Repetitive rating: Pulse width limited by max. junction temperature

## **Thermal Characteristics**

| Symbol                 | Parameter                                     | FGH50T65SQD_F155 | Unit |
|------------------------|---|------------------|------|
| $R_{\theta JC}(IGBT)$  | Thermal Resistance, Junction to Case, Max.    | 0.56             | °C/W |
| $R_{\theta JC}(Diode)$ | Thermal Resistance, Junction to Case, Max.    | 1.25             | °C/W |
| $R_{\theta JA}$        | Thermal Resistance, Junction to Ambient, Max. | 40               | °C/W |

# **Package Marking and Ordering Information**

| Part Number      | Top Mark    | Package    | Packing Method | Reel Size | Tape Width | Qty per Tube |
|------------------|-------------|------------|----------------|-----------|------------|--------------|
| FGH50T65SQD_F155 | FGH50T65SQD | TO-247 G03 | Tube           | -         | -          | 30           |

# Electrical Characteristics of the IGBT T<sub>C</sub> = 25°C unless otherwise noted

| Symbol                             | Parameter                                    | Test Conditions  | Min. | Тур. | Max. | Unit |
|------------------------------------|--|--|------|------|------|------|
| Off Charac                         | teristics                                    |  |      |      |      |      |
| BV <sub>CES</sub>                  | Collector to Emitter Breakdown Voltage       | $V_{GE}$ = 0V, $I_C$ = 1 mA  | 650  | -    | -    | V    |
| $\Delta BV_{CES}$ / $\Delta T_{J}$ | Temperature Coefficient of Breakdown Voltage | I <sub>C</sub> = 1 mA, Reference to 25°C   | -    | 0.6  | -    | V/°C |
| I <sub>CES</sub>                   | Collector Cut-Off Current                    | $V_{CE} = V_{CES}, V_{GE} = 0 V$   | -    | -    | 250  | μΑ   |
| I <sub>GES</sub>                   | G-E Leakage Current                          | $V_{GE} = V_{GES}, V_{CE} = 0 V$   | -    | -    | ±400 | nA   |
| On Charac                          | teristics                                    |  |      |      |      |      |
| V <sub>GE(th)</sub>                | G-E Threshold Voltage                        | $I_C$ = 50 mA, $V_{CE}$ = $V_{GE}$   | 2.6  | 4.5  | 6.4  | V    |
|                                    |  | I <sub>C</sub> = 50 A, V <sub>GE</sub> = 15 V, T <sub>C</sub> = 25°C                         | -    | 1.6  | 2.1  | V    |
| V <sub>CE(sat)</sub>               | Collector to Emitter Saturation Voltage      | I <sub>C</sub> = 50 A, V <sub>GE</sub> = 15 V, T <sub>C</sub> = 175°C                        | -    | 1.92 | -    | V    |
| Dynamic C                          | haracteristics                               |  |      |      | l    |      |
| C <sub>ies</sub>                   | Input Capacitance                            |  | -    | 3275 | -    | pF   |
| C <sub>oes</sub>                   | Output Capacitance                           | $V_{CE} = 30 \text{ V}, V_{GE} = 0 \text{ V},$   | -    | 84   | -    | pF   |
| C <sub>res</sub>                   | Reverse Transfer Capacitance                 | f = 1MHz   | -    | 12   | -    | pF   |
| Switching                          | Characteristics                              |  |      |      |      |      |
| t <sub>d(on)</sub>                 | Turn-On Delay Time                           |  | -    | 22   | -    | ns   |
| t <sub>r</sub>                     | Rise Time                                    |  | -    | 8.7  | -    | ns   |
| t <sub>d(off)</sub>                | Turn-Off Delay Time                          | V <sub>CC</sub> = 400 V, I <sub>C</sub> = 12.5 A,  | -    | 105  | -    | ns   |
| t <sub>f</sub>                     | Fall Time                                    | $R_G = 4.7 \Omega$ , $V_{GE} = 15 V$ ,   | -    | 2.5  | -    | ns   |
| E <sub>on</sub>                    | Turn-On Switching Loss                       | Inductive Load, T <sub>C</sub> = 25°C  | -    | 180  | -    | uJ   |
| E <sub>off</sub>                   | Turn-Off Switching Loss                      |  | -    | 45   | -    | uJ   |
| E <sub>ts</sub>                    | Total Switching Loss                         |  | -    | 225  | -    | uJ   |
| t <sub>d(on)</sub>                 | Turn-On Delay Time                           |  | -    | 19   | -    | ns   |
| t <sub>r</sub>                     | Rise Time                                    | ] [  | -    | 13   | -    | ns   |
| t <sub>d(off)</sub>                | Turn-Off Delay Time                          | $V_{CC} = 400 \text{ V}, I_{C} = 25 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GE} = 15 \text{ V},$ | -    | 93   | -    | ns   |
| t <sub>f</sub>                     | Fall Time                                    |  | -    | 6.4  | -    | ns   |
| E <sub>on</sub>                    | Turn-On Switching Loss                       | Inductive Load, T <sub>C</sub> = 25°C  | -    | 410  | -    | uJ   |
| E <sub>off</sub>                   | Turn-Off Switching Loss                      |  | -    | 88   | -    | uJ   |
| E <sub>ts</sub>                    | Total Switching Loss                         | ] [  | -    | 498  | -    | uJ   |

# Electrical Characteristics of the IGBT (Continued)

| Symbol              | Parameter                | Test Conditions   | Min. | Тур. | Max | Unit |
|---------------------|--------------------------|---|------|------|-----|------|
| t <sub>d(on)</sub>  | Turn-On Delay Time       |   | -    | 20   | -   | ns   |
| t <sub>r</sub>      | Rise Time                |   | -    | 9.8  | -   | ns   |
| t <sub>d(off)</sub> | Turn-Off Delay Time      | V <sub>CC</sub> = 400 V, I <sub>C</sub> = 12.5 A,                         | -    | 116  | -   | ns   |
| t <sub>f</sub>      | Fall Time                | $R_G = 4.7 \Omega, V_{GE} = 15 V,$  | -    | 3.5  | -   | ns   |
| E <sub>on</sub>     | Turn-On Switching Loss   | Inductive Load, T <sub>C</sub> = 175°C                                    | -    | 402  | -   | uJ   |
| E <sub>off</sub>    | Turn-Off Switching Loss  |   | -    | 110  | -   | uJ   |
| E <sub>ts</sub>     | Total Switching Loss     |   | -    | 512  | -   | uJ   |
| t <sub>d(on)</sub>  | Turn-On Delay Time       |   | -    | 18   | -   | ns   |
| t <sub>r</sub>      | Rise Time                |   | -    | 15   | -   | ns   |
| t <sub>d(off)</sub> | Turn-Off Delay Time      | V <sub>CC</sub> = 400 V, I <sub>C</sub> = 25 A,                           | -    | 102  | -   | ns   |
| t <sub>f</sub>      | Fall Time                | $R_G = 4.7 \Omega$ , $V_{GE} = 15 V$ ,                                    | -    | 8    | -   | ns   |
| E <sub>on</sub>     | Turn-On Switching Loss   | Inductive Load, T <sub>C</sub> = 175°C                                    | -    | 641  | -   | uJ   |
| E <sub>off</sub>    | Turn-Off Switching Loss  |   | -    | 203  | -   | uJ   |
| E <sub>ts</sub>     | Total Switching Loss     |   | -    | 844  | -   | uJ   |
| Qg                  | Total Gate Charge        | V 400 V 1 50 A  | -    | 99   | -   | nC   |
| Q <sub>ge</sub>     | Gate to Emitter Charge   | V <sub>CE</sub> = 400 V, I <sub>C</sub> = 50 A,<br>V <sub>GE</sub> = 15 V | -    | 17   | -   | nC   |
| Q <sub>gc</sub>     | Gate to Collector Charge | - GE :-:  | -    | 23   | -   | nC   |

# Electrical Characteristics of the Diode T<sub>C</sub> = 25°C unless otherwise noted

| Symbol           | Parameter                      | Test Conditions |                                 | Min. | Тур. | Max | Unit |
|------------------|--------------------------------|-----------------|---------------------------------|------|------|-----|------|
| V <sub>FM</sub>  | Diode Forward Voltage          | IF = 30 A       | $T_{\rm C} = 25^{\rm o}{\rm C}$ | -    | 2.2  | 2.6 | V    |
| FINI             |                                |                 | $T_{\rm C}$ = 175°C             | -    | 1.9  | -   |      |
| E <sub>rec</sub> | Reverse Recovery Energy        |                 | $T_{\rm C}$ = 175°C             | -    | 40   | -   | uJ   |
| t <sub>rr</sub>  | Diode Reverse Recovery Time    | 200 A/μs        | T <sub>C</sub> = 25°C           | -    | 31   | -   | ns   |
| पा               |                                |                 | T <sub>C</sub> = 175°C          | -    | 207  | -   | 110  |
| Q <sub>rr</sub>  | Diode Reverse Recovery Charge  |                 | T <sub>C</sub> = 25°C           | -    | 48   | -   | nC   |
| ≪rr              | Diago Novolog Neesovery Charge |                 | T <sub>C</sub> = 175°C          | -    | 820  | -   |      |

Figure 1. Typical Output Characteristics

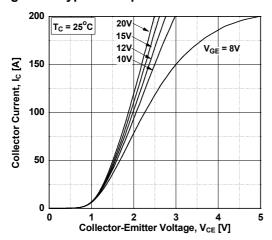


Figure 3. Typical Saturation Voltage Characteristics

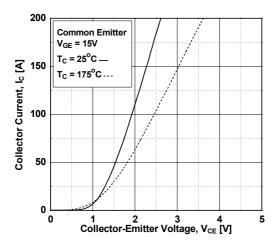
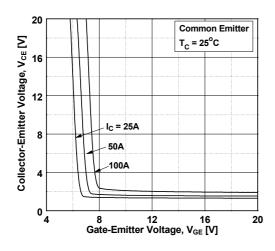


Figure 5. Saturation Voltage vs.  $V_{\text{GE}}$ 



**Figure 2. Typical Output Characteristics** 

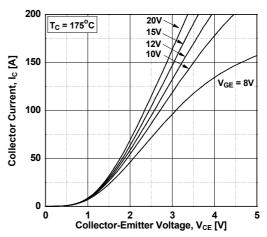


Figure 4. Saturation Voltage vs. Case
Temperature at Variant Current Level

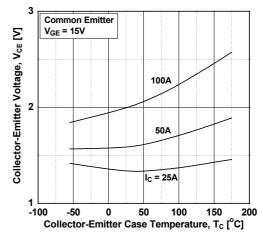


Figure 6. Saturation Voltage vs. V<sub>GE</sub>

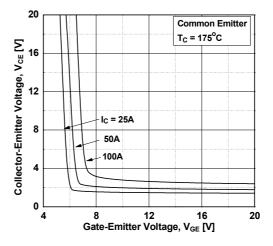


Figure 7. Capacitance Characteristics

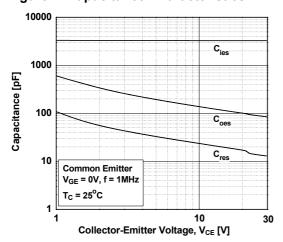


Figure 9. Turn-on Characteristics vs.
Gate Resistance

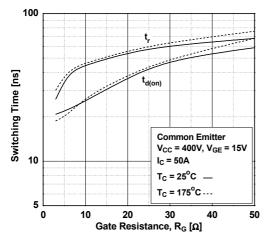


Figure 11. Switching Loss vs.
Gate Resistance

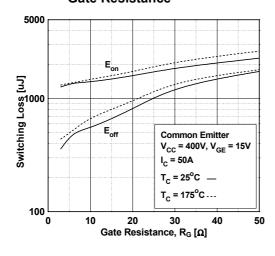


Figure 8. Gate charge Characteristics

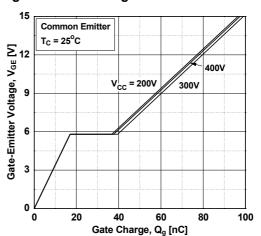


Figure 10. Turn-off Characteristics vs. Gate Resistance

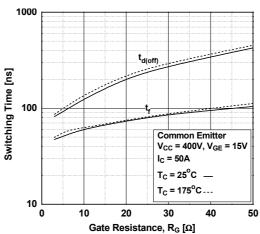


Figure 12. Turn-on Characteristics vs. Collector Current

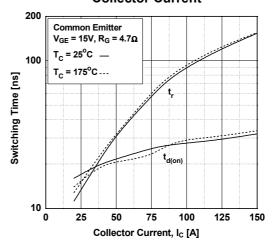
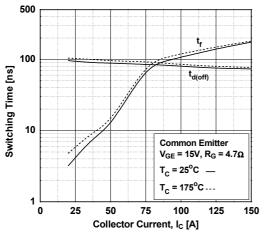


Figure 13. Turn-off Characteristics vs. Collector Current



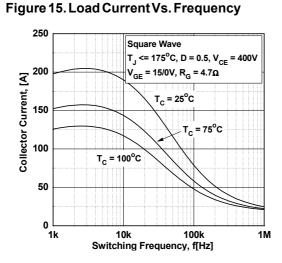


Figure 17. Forward Characteristics

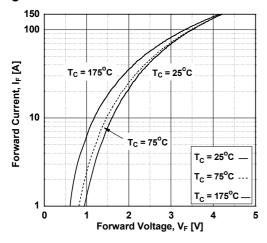


Figure 14. Switching Loss vs. Collector Current

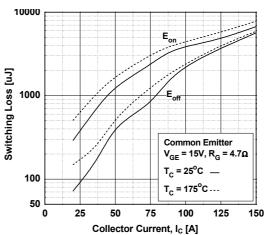


Figure 16. SOA Characteristics

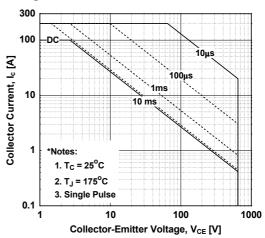


Figure 18. Reverse Recovery Current

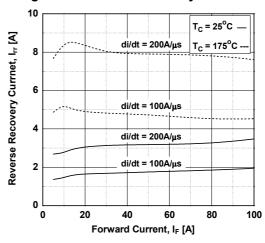


Figure 19. Reverse Recovery Time

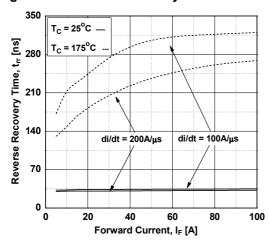


Figure 20. Stored Charge

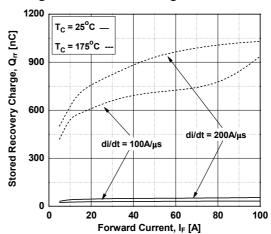


Figure 21.Transient Thermal Impedance of IGBT

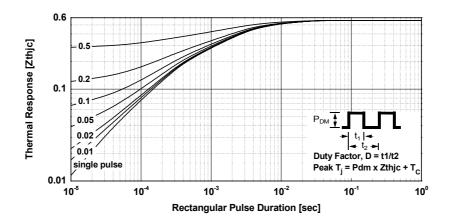
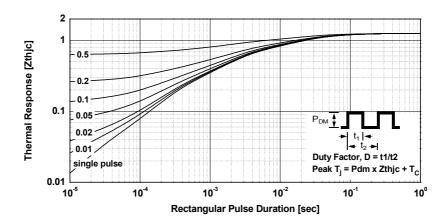
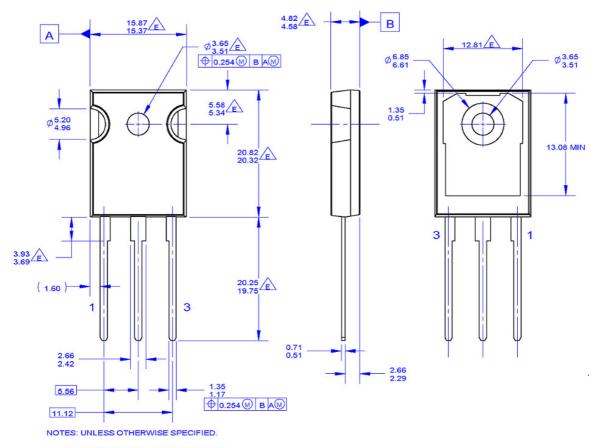


Figure 22. Transient Thermal Impedance of Diode



#### **Mechanical Dimensions**



- A. PACKAGE REFERENCE: JEDEC TO-247,
- A. PACKAGE REFERENCE: JEDEC 10-247,
   ISSUE E, VARIATION AB, DATED JUNE, 2004.
   B. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH, AND TIE BAR EXTRUSIONS.
   C. ALL DIMENSIONS ARE IN MILLIMETERS.
   D. DRAWING CONFORMS TO ASME Y14.5 1994

- DOES NOT COMPLY JEDEC STANDARD VALUE
  F. DRAWING FILENAME: MKT-T0247G03\_REV01

Figure 23. TO-247 3L - TO-247, MOLDED, 3 LEADS, JEDEC AB LONG LEADS

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#### **PRODUCT STATUS DEFINITIONS**

#### **Definition of Terms**

| Datasheet Identification | Product Status        | Definition  |
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